

<b>Notice of References Cited</b>	Application/Control No. 10/024,145	Applicant(s)/Patent Under Reexamination NAKAYAMA, SHIGERU	
	Examiner Andrew H. Lee	Art Unit 2877	Page 1 of 1

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	B	US-5,184,196	02-1993	Nakagawa et al.	356/401
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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